General Description

The SJH40PD085 uses advanced trench technology to provide excellent R_{DS(ON)}, low gate charge and operation with gate voltages as low as -4.5V. This device is suitable for use as a wide variety of applications.

Features

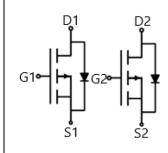
- Low Gate Charge
- 100% UIS Tested, 100% DVDS Tested
- High Power and current handing capability
- Lead free product is acquired

Application

- PWM Applications
- Load Switch
- Power Management

Key Performance Parametes

Parameter	Value	Unit
V _{DS}	-40	V
R _{DS(ON)_TYP}	10.9	mΩ
ID	-45	A
Q _G	60	nC









Schematic Diagram

PDFN5X6-8L top&bottom view

Package Marking and Ordering Information

Device/Ordering Code	Marking	Package	Packing	Reel Size	Tape width	Quantity
SJH40PD085	SJH40PD085	PDFN5X6-8L	Tape	\	/	5000 Pcs

Table 1. Absolute Maximum Ratings (T_C=25℃ unless otherwise noted)

Symbol	Parameter	Limit	Unit
V _{DS}	Drain-Source Voltage (V _{GS} =0V)	-40	V
V _G S	Gate-Source Voltage (V _{DS} =0V)	±20	V
1-	Drain Current-Continuous(Tc=25℃)	-45	А
I _D	Drain Current-Continuous(Tc=100℃)	-28	А
I _{DM} (pluse)	Drain Current-Continuous@ Current-Pulsed (Note 1)	-180	А
D	Maximum Power Dissipation(Tc=25°ℂ)	50	W
P _D	Maximum Power Dissipation(T _C =100°C)	20	W
Eas	Avalanche energy (Note 2)	272	mJ
TJ, TSTG	Operating Junction and Storage Temperature Range	-55 To 150	С

Table 2. Thermal Characteristic

Symbol	Parameter	Тур	Max	Unit
R _θ JC	Thermal Resistance, Junction-to-Case		2.48	°C/W



Table 3. Electrical Characteristics (T_J=25℃ unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
On/Off States						
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V I _D =-250μA	-40			V
	7 0 1 1/1 5 1 0 1	V _{DS} =-40V, V _{GS} =0V T _J =25°C			-1	μΑ
IDSS	Zero Gate Voltage Drain Current	V _{DS} =-40V, V _{GS} =0V T _J =125°C			-100	μA
Igss	Gate-Body Leakage Current	V _{GS} =±20V, V _{DS} =0V			±100	nA
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =-250μA	-1		-2.5	V
g FS	Forward Transconductance	V _{DS} =-5V, I _D =-10A		31		S
R _{DS(ON)}	Drain-Source On-State Resistance	V _{GS} =-10V, I _D =-20A T _J =25℃		10.9	14.2	mΩ
R _{DS(ON)}	Drain-Source On-State Resistance	V _{GS} =-4.5V, I _D =-20A T _J =25°C		14.5	19.3	mΩ
Dynamic Chara	acteristics					
Ciss	Input Capacitance			3241		pF
Coss	Output Capacitance	V _{DS} =-20V,V _{GS} =0V, f=1.0MHz		228		pF
C _{rss}	Reverse Transfer Capacitance			205		pF
Rg	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1.0MHz		4.5		Ω
Switching Para	meters					
t _{d(on)}	Turn-on Delay Time			18		nS
tr	Turn-on Rise Time	V _{GS} =-10V, V _{DS} =-20V,		4.8		nS
$t_{d(off)}$	Turn-Off Delay Time	R _L =1Ω, R _{GEN} =3Ω		88.8		nS
t _f	Turn-Off Fall Time			26.4		nS
Qg	Total Gate Charge			60		nC
Qgs	Gate-Source Charge	V _{GS} =-10V, V _{DS} =-20V, I _D =-20A		8.6		nC
Q_{gd}	Gate-Drain Charge			13.9		nC
Source-Drain D	Diode Characteristics					
I _{SD}	Source-Drain Current (Body Diode)				-45	А
V _{SD}	Forward on Voltage (Note 3)	V _{GS} =0V, I _S =-10A			-1.2	V
t _{rr}	Reverse Recovery Time	I _F =-10A, dI/dt=-100A/μs		17.3		ns
					t	

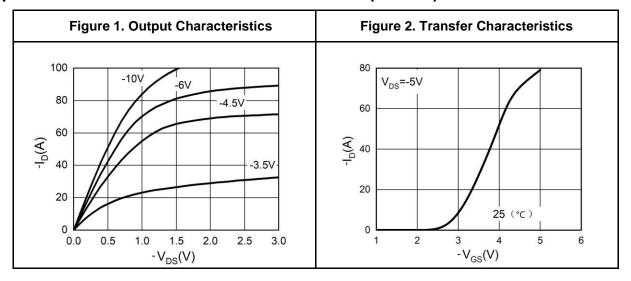
Notes 1.Repetitive Rating: Pulse width limited by maximum junction temperature.

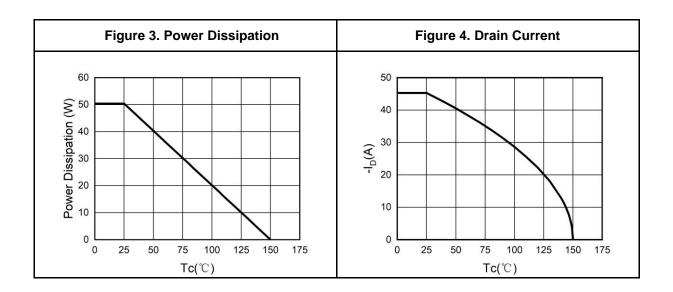
Notes 2.E_{AS} condition: $T_J=25^{\circ}C$, $V_{DD}=-40V$, $V_{G}=-10V$, $Rg=25\Omega$, L=0.5mH.

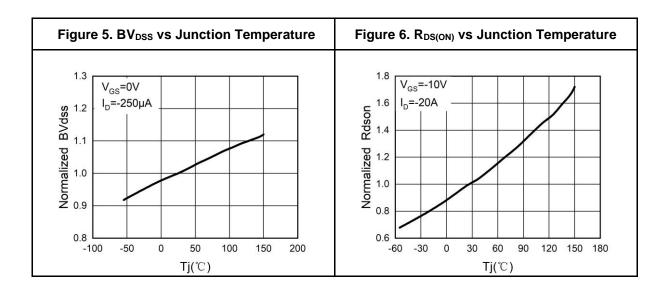
Notes 3.Repetitive Rating: Pulse width limited by maximum junction temperature.



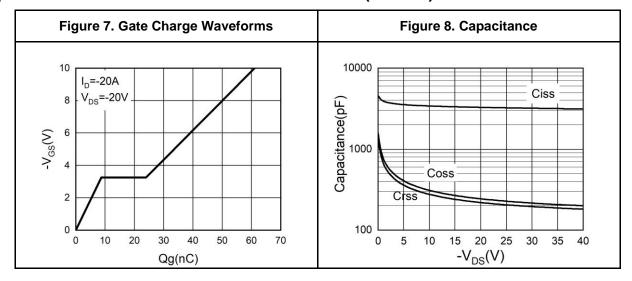
Typical Electrical And Thermal Characteristics (Curves)

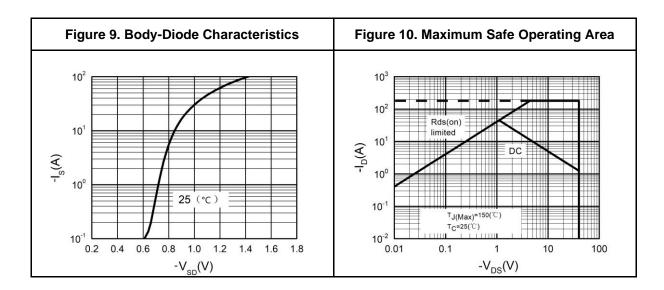






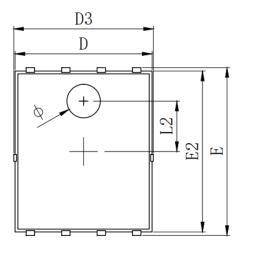
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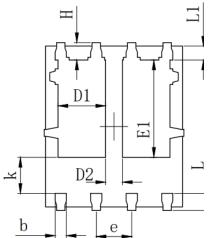




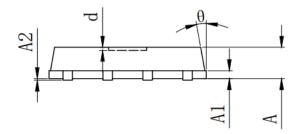








SYMBOL]	MILLIMETER	
SIMDOL	MIN	Тур.	MAX
A	0.900	1.000	1. 100
A1		0.254 REF.	
A2		0~0.05	
D	4. 824	4.900	4. 976
D1	1.605	1. 705	1.805
D2	0.500	0.600	0.700
D3	4. 924	5.000	5. 076
E	5. 924	6.000	6.076
E1	3. 375	3. 475	3. 575
E2	5. 674	5. 750	5. 826
b	0.350	0.400	0.450
е		1.270 TYP.	
L	0.534	0.610	0. 686
L1	0. 424	0.500	0. 576
L2		1.800 REF.	
k	1. 190	1. 290	1. 390
Н	0. 549	0.625	0. 701
θ	8°	10°	12°
ф	1. 100	1.200	1.300
d			0.100



Symbol	MILLIMETER					
Symbol	Min.	Тур.	Max.			
Α	0.900	1.000	1.100			
A1		0.254 REF.				
A2		0~0.05				
D	4.824	4.900	4.976			
D1	3.910	4.010	4.110			
D2	4.924	5.000	5.076			
E	5.924	6.000	6.076			
E1	3.375	3.475	3.575			
E2	5.674	5.75	5.826			
b	0.350	0.400	0.450			
е		1.270 TYP.				
L	0.534	0.610	0.686			
L1	0.424	0.500	0.576			
L2		1.800 REF.				
k	1.190	1.290	1.390			
Н	0.549	0.625	0.701			
θ	8°	10°	12°			
Ф	1.100	1.200	1.300			
d			0.100			



Attention

This product described in this document can not be used in life support devices or systems, aircraft's control systems, and other applications whose failure can be reasonably expected to result in serious physical and/or material damage, apart from that when an application agreement is signed between customer and Wuxi Shangjia Semiconductor.

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